Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/768,234	HUNLETH ET AL.
Examiner	Art Unit
Le Nguyen	2174

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			147
	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EPO, JPO	9/27/2007	LVN		
US-PGPub, USPAT: 715/838,708,711,767,802,822,823, 859,860,719-732,716,739; 725/37-61	9/27/2007	LVN		
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